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| Notice of References Cited | Application/Control No. 10/693,097 | Applicant(s)/Patent Under Reexamination RIMER ET AL. | |
| | Examiner Thuy N. Pardo | Art Unit 2165 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| * | A | US-5,542,078 | 07-1996 | Martel et al. | 707/101 |
| * | B | US-5,778,395 | 07-1998 | Whiting et al. | 707/204 |
| * | C | US-2002/0114522 | 08-2002 | Seeber, Rene | 382/218 |
| * | D | US-2003/0236859 | 12-2003 | Vaschillo et al. | 709/218 |
| * | E | US-2004/0019874 | 01-2004 | Edwards et al. | 717/106 |
| * | F | US-2004/0044837 | 03-2004 | Hasbun et al. | 711/103 |
| * | G | US-2004/0078782 | 04-2004 | Clement et al. | 717/116 |
| * | H | US-2004/0093587 | 05-2004 | Sesma, Charles | 717/118 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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